## Notice of References Cited Application/Control No. 10/658,412 Examiner Brian R. Gordon Applicant(s)/Patent Under Reexamination HIGUCHI, AKIRA Page 1 of 1

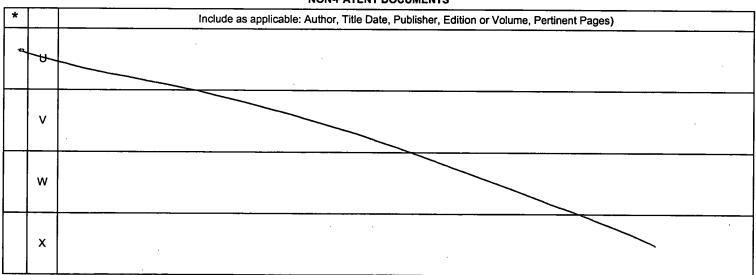
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